



P-CHANNEL MOSFET

Qualified per MIL-PRF-19500/564

Qualified Levels:
JAN, JANTX, JANTXV
and JANS

DESCRIPTION

This 2N6849U switching transistor is military qualified up to the JANS level for high-reliability applications. This device is also available in a thru hole TO-205AF package. Microsemi also offers numerous other transistor products to meet higher and lower power ratings with various switching speed requirements in both through-hole and surface-mount packages.

Important: For the latest information, visit our website <http://www.microsemi.com>.

FEATURES

- Surface mount equivalent of JEDEC registered 2N6849 number.
- JAN, JANTX, JANTXV and JANS qualifications are available per MIL-PRF-19500/564. (See [part nomenclature](#) for all available options.)
- RoHS compliant by design.

APPLICATIONS / BENEFITS

- Low profile surface mount for crowded areas.
- Military and other high-reliability applications.

MAXIMUM RATINGS @ T_A = +25 °C unless otherwise stated

Parameters / Test Conditions	Symbol	Value	Unit
Operating & Storage Junction Temperature Range	T _J & T _{stg}	-55 to +150	°C
Thermal Resistance Junction-to-Case	R _{θJC}	5.0	°C/W
Total Power Dissipation @ T _A = +25 °C @ T _C = +25 °C ⁽¹⁾	P _T	0.8 25	W
Drain-Source Voltage, dc	V _{DS}	-100	V
Gate-Source Voltage, dc	V _{GS}	± 20	V
Drain Current, dc @ T _C = +25 °C ⁽²⁾	I _{D1}	-6.5	A
Drain Current, dc @ T _C = +100 °C ⁽²⁾	I _{D2}	-4.1	A
Off-State Current (Peak Total Value) ⁽³⁾	I _{DM}	-25	A (pk)
Source Current	I _S	-6.5	A

Notes: 1. Derate linearly 0.2 W/°C for T_C > +25 °C.

2. The following formula derives the maximum theoretical I_D limit. I_D is also limited by package and internal wires and may be limited due to pin diameter.

$$I_D = \sqrt{\frac{T_J(\text{max}) - T_C}{R_{\theta JC} \times R_{DS(on)} @ T_J(\text{max})}}$$

3. I_{DM} = 4 × I_{D1} as calculated in note 2.



**U-18 LCC
Package**

Also available in:

**TO-205AF (TO-39)
package**

(Leaded Top Hat)



MSC – Lawrence

6 Lake Street,
Lawrence, MA 01841
Tel: 1-800-446-1158 or
(978) 620-2600
Fax: (978) 689-0803

MSC – Ireland

Gort Road Business Park,
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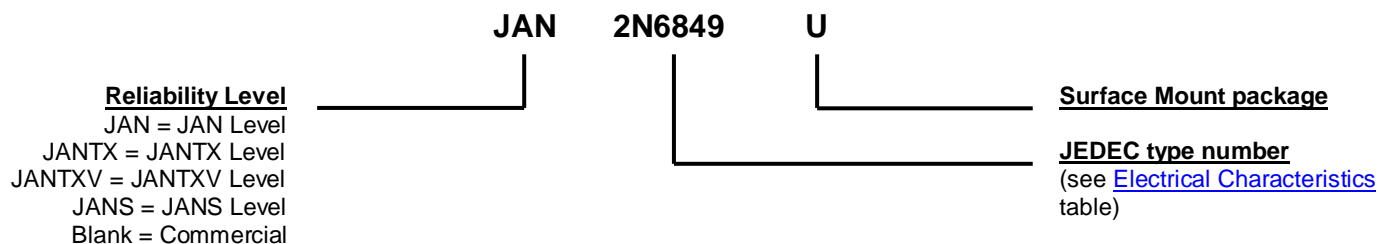
Website:

www.microsemi.com

MECHANICAL and PACKAGING

- CASE: Ceramic LCC-18 with kovar gold plated lid.
- TERMINALS: Gold plating over nickel.
- MARKING: Manufacturer's ID, part number, date code, ESD symbol at pin 1 location.
- TAPE & REEL option: Standard per EIA-481-D. Consult factory for quantities.
- See [Package Dimensions](#) on last page.

PART NOMENCLATURE



SYMBOLS & DEFINITIONS

Symbol	Definition
di/dt	Rate of change of diode current while in reverse-recovery mode, recorded as maximum value.
I_F	Forward current
R_G	Gate drive impedance
V_{DD}	Drain supply voltage
V_{DS}	Drain source voltage, dc
V_{GS}	Gate source voltage, dc

ELECTRICAL CHARACTERISTICS @ $T_A = +25\text{ }^{\circ}\text{C}$, unless otherwise noted

Parameters / Test Conditions	Symbol	Min.	Max.	Unit
OFF CHARACTERISTICS				
Drain-Source Breakdown Voltage $V_{GS} = 0\text{ V}$, $I_D = -1.0\text{ mA}$	$V_{(BR)DSS}$	-100		V
Gate-Source Voltage (Threshold) $V_{DS} \geq V_{GS}$, $I_D = -0.25\text{ mA}$ $V_{DS} \geq V_{GS}$, $I_D = -0.25\text{ mA}$, $T_J = +125^{\circ}\text{C}$ $V_{DS} \geq V_{GS}$, $I_D = -0.25\text{ mA}$, $T_J = -55^{\circ}\text{C}$	$V_{GS(th)1}$ $V_{GS(th)2}$ $V_{GS(th)3}$	-2.0 -1.0	-4.0 -5.0	V
Gate Current $V_{GS} = \pm 20\text{ V}$, $V_{DS} = 0\text{ V}$ $V_{GS} = \pm 20\text{ V}$, $V_{DS} = 0\text{ V}$, $T_J = +125^{\circ}\text{C}$	I_{GSS1} I_{GSS2}		± 100 ± 200	nA
Drain Current $V_{GS} = 0\text{ V}$, $V_{DS} = -80\text{ V}$	I_{DSS1}		-25	μA
Drain Current $V_{GS} = 0\text{ V}$, $V_{DS} = -80\text{ V}$, $T_J = +125\text{ }^{\circ}\text{C}$	I_{DSS2}		-0.25	mA
Static Drain-Source On-State Resistance $V_{GS} = -10\text{ V}$, $I_D = -4.1\text{ A}$ pulsed	$r_{DS(on)1}$		0.30	Ω
Static Drain-Source On-State Resistance $V_{GS} = -10\text{ V}$, $I_D = -6.5\text{ A}$ pulsed	$r_{DS(on)2}$		0.32	Ω
Static Drain-Source On-State Resistance $T_J = +125^{\circ}\text{C}$ $V_{GS} = -10\text{ V}$, $I_D = -4.1\text{ A}$ pulsed	$r_{DS(on)3}$		0.54	Ω
Diode Forward Voltage $V_{GS} = 0\text{ V}$, $I_D = -6.5\text{ A}$ pulsed	V_{SD}		-4.3	V

DYNAMIC CHARACTERISTICS

Parameters / Test Conditions	Symbol	Min.	Max.	Unit
Gate Charge:				
On-State Gate Charge $V_{GS} = -10\text{ V}$, $I_D = -6.5\text{ A}$, $V_{DS} = -50\text{ V}$	$Q_{g(on)}$		34.8	nC
Gate to Source Charge $V_{GS} = -10\text{ V}$, $I_D = -6.5\text{ A}$, $V_{DS} = -50\text{ V}$	Q_{gs}		6.8	nC
Gate to Drain Charge $V_{GS} = -10\text{ V}$, $I_D = -6.5\text{ A}$, $V_{DS} = -50\text{ V}$	Q_{gd}		23.1	nC

ELECTRICAL CHARACTERISTICS @ $T_A = +25\text{ }^{\circ}\text{C}$, unless otherwise noted (continued)**SWITCHING CHARACTERISTICS**

Parameters / Test Conditions	Symbol	Min.	Max.	Unit
Turn-on delay time $I_D = -6.5\text{ A}$, $V_{GS} = -10\text{ V}$, $R_G = 7.5\text{ }\Omega$, $V_{DD} = -40\text{ V}$	$t_{d(on)}$		60	ns
Rinse time $I_D = -6.5\text{ A}$, $V_{GS} = -10\text{ V}$, $R_G = 7.5\text{ }\Omega$, $V_{DD} = -40\text{ V}$	t_r		140	ns
Turn-off delay time $I_D = -6.5\text{ A}$, $V_{GS} = -10\text{ V}$, $R_G = 7.5\text{ }\Omega$, $V_{DD} = -40\text{ V}$	$t_{d(off)}$		140	ns
Fall time $I_D = -6.5\text{ A}$, $V_{GS} = -10\text{ V}$, $R_G = 7.5\text{ }\Omega$, $V_{DD} = -40\text{ V}$	t_f		140	ns
Diode Reverse Recovery Time $di/dt \leq -100\text{ A}/\mu\text{s}$, $V_{DD} \leq -50\text{ V}$, $I_F = -6.5\text{ A}$	t_{rr}		250	ns

GRAPHS

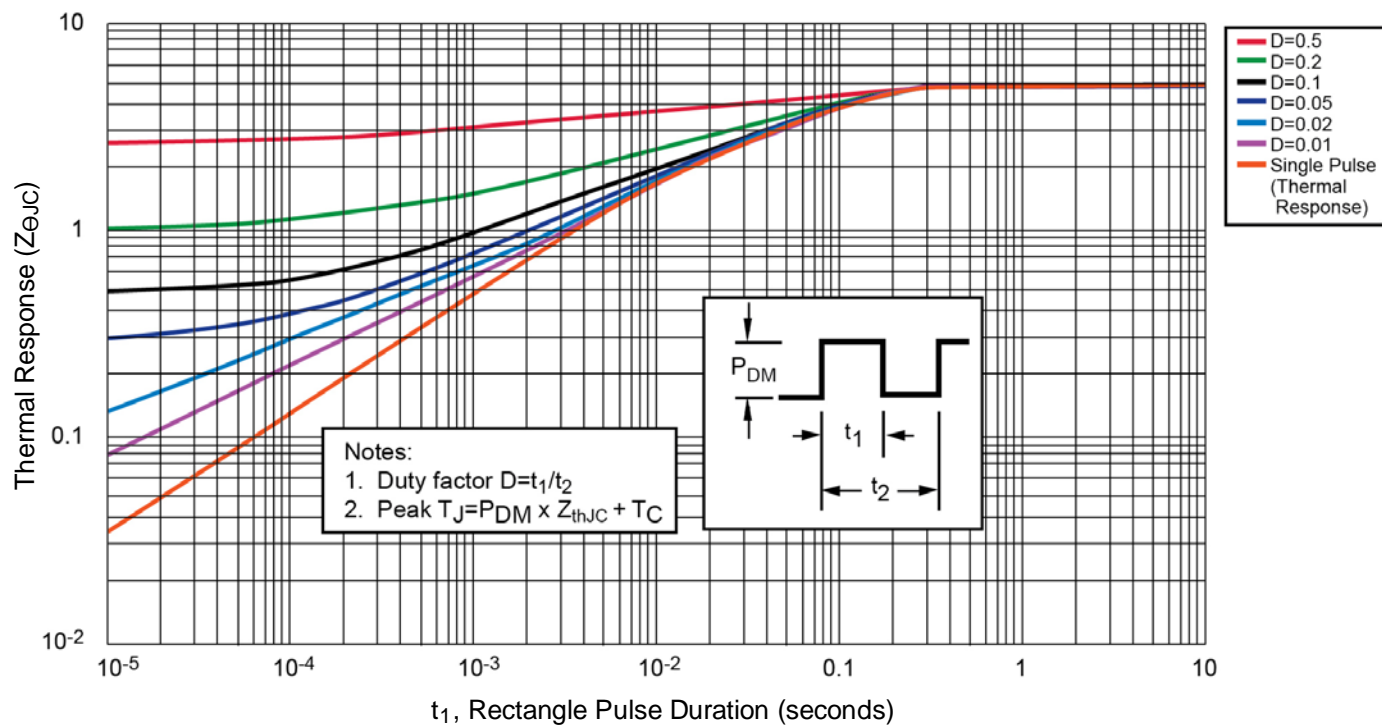


FIGURE 1 – Normalized Transient Thermal Impedance

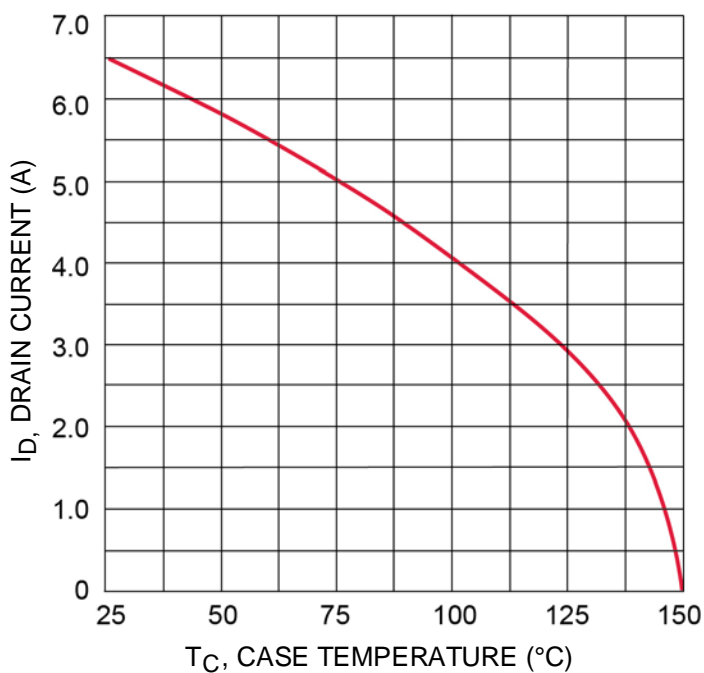


FIGURE 2 – Maximum Drain Current vs Case Temperature

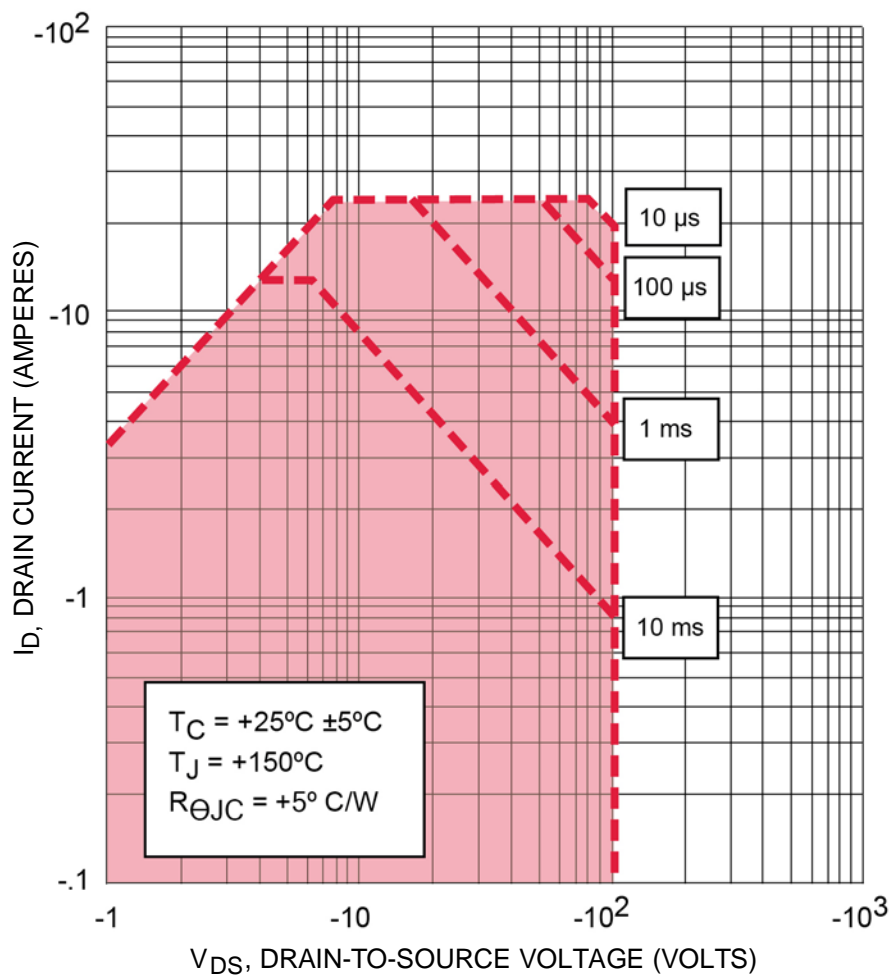
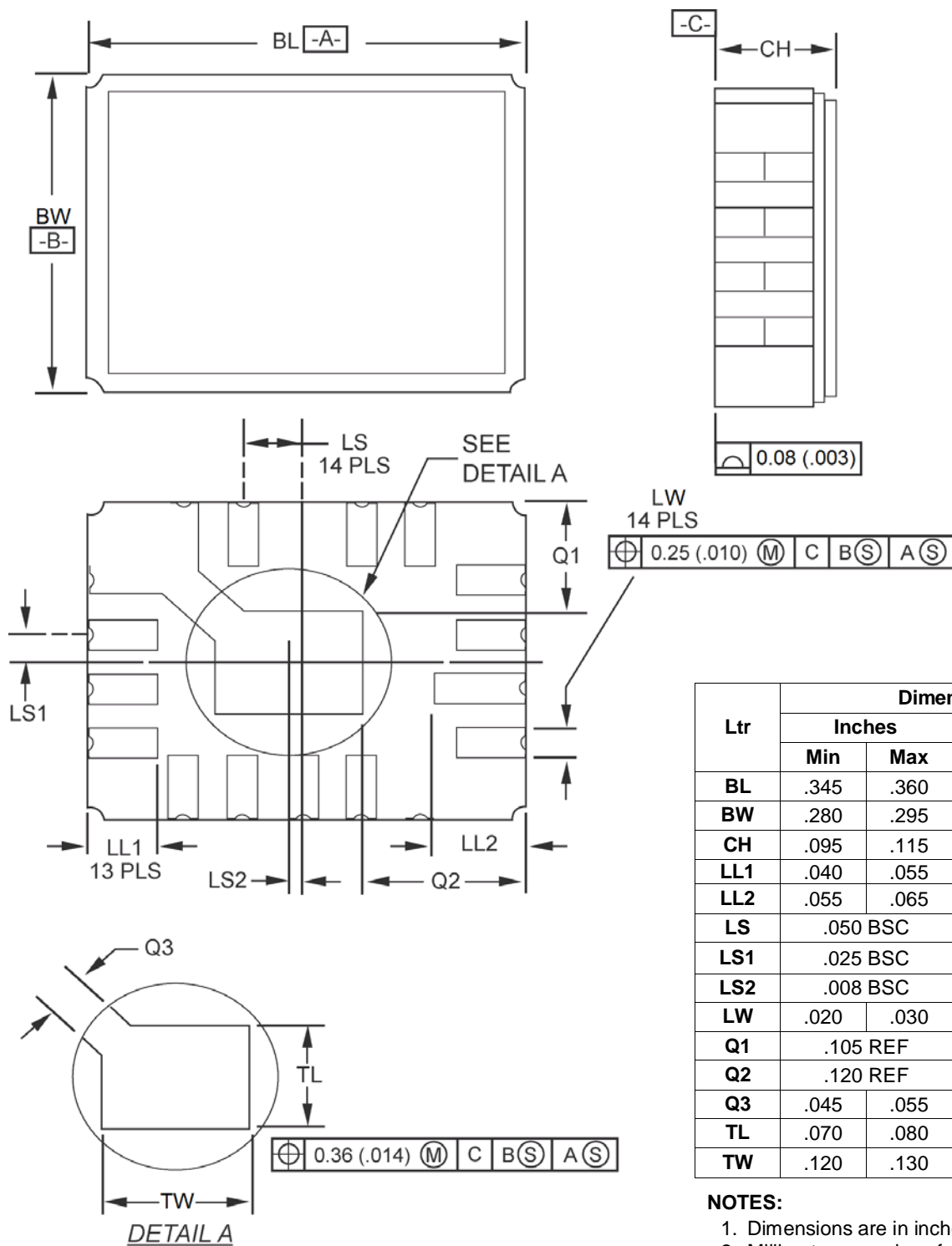
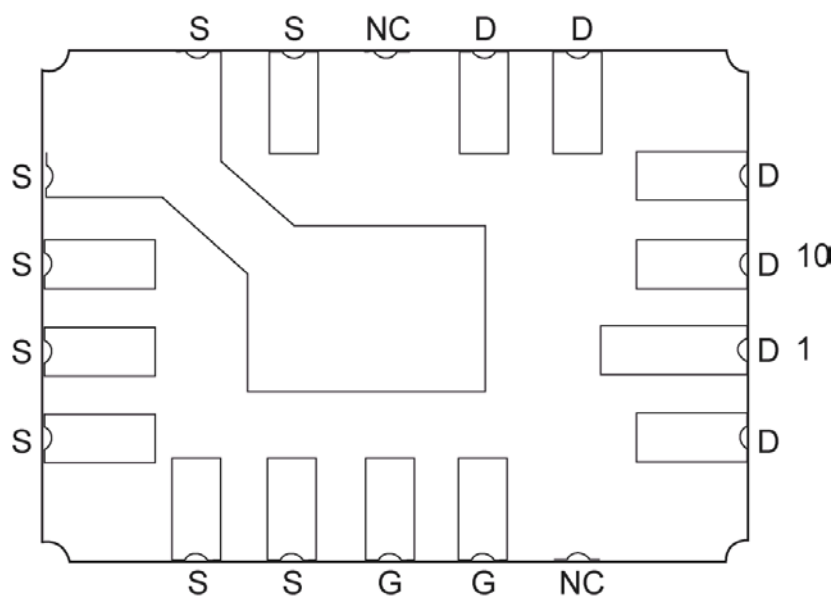
GRAPHS (continued)


FIGURE 3 – Maximum Safe Operating Area

PACKAGE DIMENSIONS

NOTES:

1. Dimensions are in inches.
2. Millimeters are given for general information only.
3. In accordance with ASME Y14.5M, diameters are equivalent to Φ x symbology.
4. Ceramic package only.

PAD LAYOUT

PAD ASSIGNMENTS